

PC844X Series

*1-channel package type is also available. (model No. **PC814X Series**)

DIP 16pin (4-channel) AC Input Photocoupler



■ Description

PC844X Series contains an IRED optically coupled to a phototransistor.

It is packaged in a 4-channel 16pin DIP.
Input-output isolation voltage(rms) is 5.0kV.
Collector-emitter voltage is 80V(*) and CTR is 20% to 300% at input current of ±1mA.

■ Features

- 1. 16pin DIP 4-channel package
- Double transfer mold package (Ideal for Flow Soldering)
- 3. AC input type
- 4. High collector-emitter voltage (V_{CEO}: 80V(*))
- 5. Current transfer ratio

(CTR: MIN. 20% at $I_{F}=\pm 1$ mA, $V_{CE}=5V$)

- 6. High isolation voltage between input and output (V_{iso(rms)}: 5.0kV)
 - (*) Up to Date code "P7" (July 2002) V_{CEO}: 35V. From the production Date code "J5" (May 1997) to "P7" (July 2002), however the products were screened by BV_{CEO}≥70V.

■ Agency approvals/Compliance

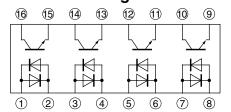
- Recognized by UL1577, file No. E64380 (as model No. PC844)
- 2. Package resin : UL flammability grade (94V-0)

■ Applications

- 1. Programmable controllers
- 2. Telephone sets, telephone exchangers
- 3. System appliances
- 4. Signal tranmission between circuits of different potentials and impedances



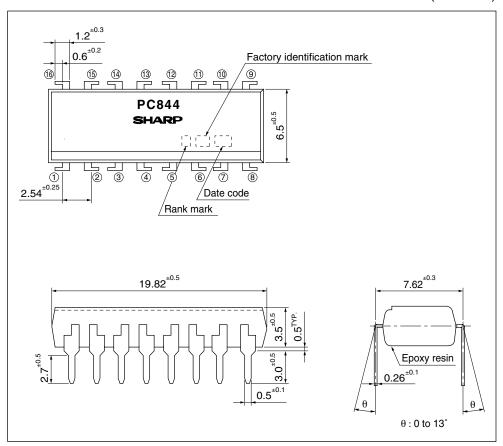
■ Internal Connection Diagram



①③⑤⑦ Anode/Cathode ②④⑥⑧ Cathode/Anode ⑨①③⑤ Emitter ⑩②④⑥ Collector

■ Outline Dimensions

(Unit: mm)



Product mass: approx. 1.0g



Date code (2 digit)

	1st o	digit		2nd digit		
Year of production				Month of production		
A.D.	Mark	A.D	Mark	Month	Mark	
1990	A	2002	P	January	1	
1991	В	2003	R	February	2	
1992	С	2004	S	March	3	
1993	D	2005	T	April	4	
1994	Е	2006	U	May	5	
1995	F	2007	V	June	6	
1996	Н	2008	W	July	7	
1997	J	2009	X	August	8	
1998	K	2010	A	September	9	
1999	L	2011	В	October	0	
2000	M	2012	С	November	N	
2001	N	:	:	December	D	

repeats in a 20 year cycle

Factory identification mark

Factory identification Mark	Country of origin	
no mark	- Japan	
	Indonesia	
$\overline{\hspace{1cm}}$	Philippines	
_	China	

^{*} This factory marking is for identification purpose only.

Please contact the local SHARP sales representative to see the actual status of the production.

Rank mark

Refer to the Model Line-up table



■ Absolute Maximum Ratings

■ Absolute Maximum Ratings $(T_a=25^{\circ}C)$							
	Parameter	Symbol	Rating	Unit			
	Forward current	I_{F}	±50	mA			
Input	*1 Peak forward current	I_{FM}	±1	A			
Inj	Reverse voltage	V_R	6	V			
	Power dissipation	P	70	mW			
	Collector-emitter voltage	V_{CEO}	*4 80	V			
Output	Emitter-collector voltage	V _{ECO}	6	V			
Out	Collector current	I_C	50	mA			
	Collector power dissipation	P_{C}	150	mW			
Total power dissipation		P_{tot}	200	mW			
*2 Isolation voltage		V _{iso (rms)}	5.0	kV			
Operating temperature		T_{opr}	-30 to +100	°C			
Storage temperature		T_{stg}	-55 to +125	°C			
*3 Soldering temperature		T_{sol}	260	°C			

■ Electro-optical Characteristics

 $(T_a=25^{\circ}C)$

	Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
ıt	Forward voltage		V_F	$I_F=\pm 20mA$	-	1.2	1.4	V
Input	Peak forward volta	age	V_{FM}	$I_{FM}=\pm0.5V$	_	_	3.0	V
<u>1</u>	Terminal capacitar	nce	C_{t}	V=0, $f=1kHz$	_	50	250	pF
nt			I_{CEO}	V_{CE} =50V, I_F =0	_	_	100	nA
utp	Collector-emitter breakdown voltage		BV_{CEO}	$I_{C}=0.1 \text{ mA}, I_{F}=0$	*5 80	_	_	V
Ō	Emitter-collector breakdown voltage		BV_{ECO}	$I_{E}=10\mu A, I_{F}=0$	6	_	_	V
ics	Collector current Collector-emitter saturation voltage Isolation resistance Floating capacitance		I_{C}	$I_F=\pm 1 \text{mA}, V_{CE}=5 \text{V}$	0.2	-	3.0	mA
rist			V _{CE (sat)}	$I_F=\pm 20mA$, $I_C=1mA$	_	0.1	0.2	V
acte	Isolation resistance	e	R_{ISO}	DC500V, 40 to 60%RH	5×10 ¹⁰	1×10 ¹¹	_	Ω
har	Floating capacitance		C_{f}	V=0, f=1MHz	_	0.6	1.0	pF
	Cut-off frequency		f_c	V_{CE} =5 V , I_{C} =2 m A, R_{L} =100 Ω , -3 d B	15	80	-	kHz
Transfer	Response time	Rise time	t _r	V_{CE} =2 V , I_{C} =2 mA , R_{L} =100 Ω	_	4	18	μs
<u> </u>		Fall time	t_{f}		_	3	18	μs

^{*5} From the production Date code "J5" (May 1997) to "P7" (July 2002), however the products were screened by BV_{CEO}≥70V.

^{*1} Pulse width≤100µs, Duty ratio : 0.001 *2 40 to 60%RH, AC for 1 minute, f = 60Hz *3 For 10s

^{*4} Up to Date code "P7" (July 2002) V_{CEO}: 35V.



■ Model Line-up

包装形態	スリーブ 25個/スリーブ	ランクマーク	I _C [mA] (I _F =±1.0mA, V _{CE} =5V, T _a =25°C)
Model No.	PC844X	有り又は無し	0.2 to 3.0
	PC844X1	A	0.5 to 1.5

Please contact a local SHARP sales representative to inquire about production status and Lead-Free options.



Fig.1 Forward Current vs. Ambient Temperature

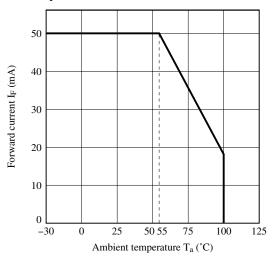


Fig.3 Collector Power Dissipation vs.
Ambient Temperature

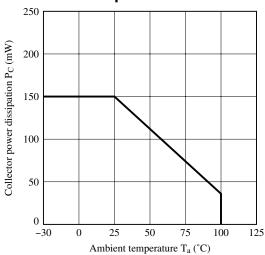


Fig.5 Peak Forward Current vs. Duty Ratio

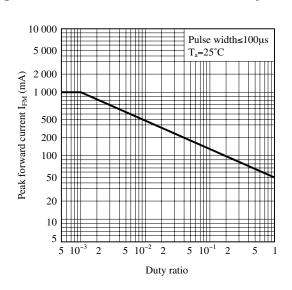


Fig.2 Diode Power Dissipation vs.
Ambient Temperature

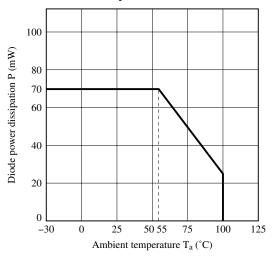


Fig.4 Total Power Dissipation vs. Ambient Temperature

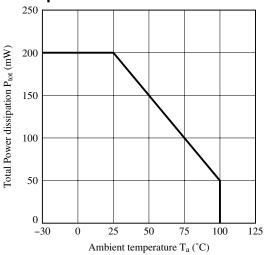


Fig.6 Forward Current vs. Forward Voltage

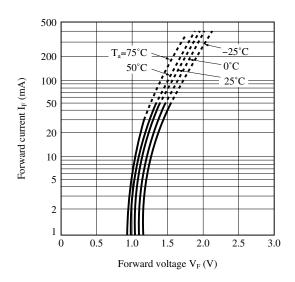




Fig.7 Current Transfer Ratio vs. Forward Current

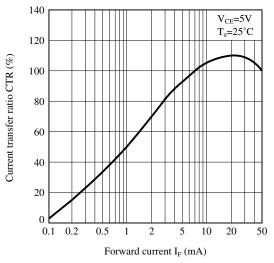


Fig.9 Relative Current Transfer Ratio vs.
Ambient Temperature

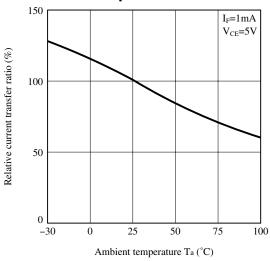


Fig.11 Collector Dark Current vs. Ambient Temperature

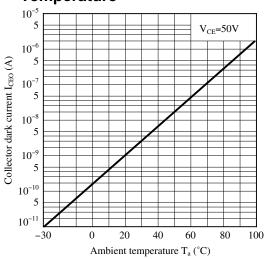


Fig.8 Collector Current vs. Collector-emitter Voltage

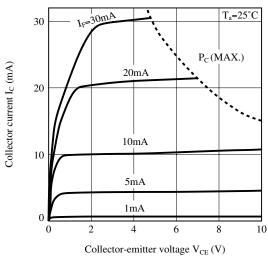


Fig.10 Collector - emitter Saturation Voltage vs. Ambient Temperature

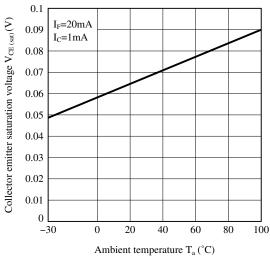


Fig.12 Collector-emitter Saturation Voltage vs. Forward Current

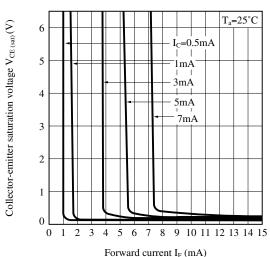




Fig.13 Response Time vs. Load Resistance

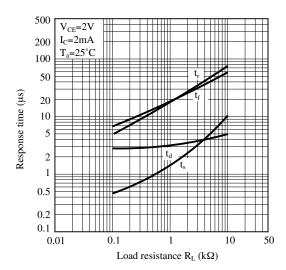


Fig.15 Frequency Response

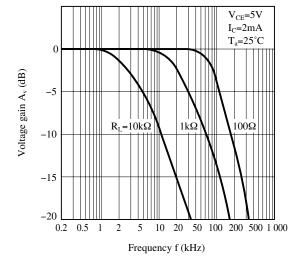
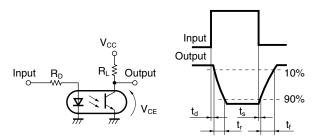
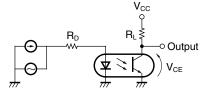


Fig.14 Test Circuit for Response Time



Please refer to the conditions in Fig.13.

Fig.16 Test Circuit for Frequency Response



Please refer to the conditions in Fig.15.

Remarks: Please be aware that all data in the graph are just for reference and not for guarantee.



■ Design Considerations

Design guide

While operating at I_F<1.0mA, CTR variation may increase.

Please make design considering this fact.

This product is not designed against irradiation and incorporates non-coherent IRED.

Degradation

In general, the emission of the IRED used in photocouplers will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5years) into the design consideration.

[☆] For additional design assistance, please review our corresponding Optoelectronic Application Notes.



■ Manufacturing Guidelines

Soldering Method

Flow Soldering:

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270°C and within 10s.

Preheating is within the bounds of 100 to 150°C and 30 to 80s.

Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400°C.

Please don't solder more than twice.

Other notices

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.

Cleaning instructions

Solvent cleaning:

Solvent temperature should be 45°C or below Immersion time should be 3minutes or less

Ultrasonic cleaning:

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials:

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this device.

Regulation substances: CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.



■ Package specification

Sleeve package

Package materials

Sleeve: HIPS (with anti-static material)

Stopper: Styrene-Elastomer

Package method

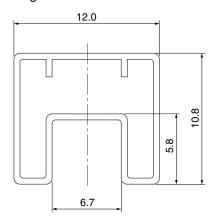
MAX. 25pcs of products shall be packaged in a sleeve. Both ends shall be closed by tabbed and tabless stoppers.

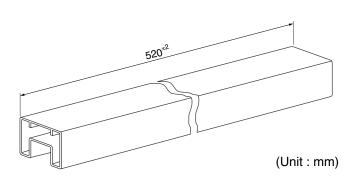
The product shall be arranged in the sleeve with its primary side mark on the tabless stopper side.

MAX. 20 sleeves in one case.

Sleeve outline dimensions

Through-Hole







■ Important Notices

- · The circuit application examples in this publication are provided to explain representative applications of SHARP devices and are not intended to guarantee any circuit design or license any intellectual property rights. SHARP takes no responsibility for any problems related to any intellectual property right of a third party resulting from the use of SHARP's devices.
- · Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device. SHARP reserves the right to make changes in the specifications, characteristics, data, materials, structure, and other contents described herein at any time without notice in order to improve design or reliability. Manufacturing locations are also subject to change without notice.
- · Observe the following points when using any devices in this publication. SHARP takes no responsibility for damage caused by improper use of the devices which does not meet the conditions and absolute maximum ratings to be used specified in the relevant specification sheet nor meet the following conditions:
- (i) The devices in this publication are designed for use in general electronic equipment designs such as:
 - --- Personal computers
 - --- Office automation equipment
 - --- Telecommunication equipment [terminal]
 - --- Test and measurement equipment
 - --- Industrial control
 - --- Audio visual equipment
 - --- Consumer electronics
- (ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection

with equipment that requires higher reliability such as:

- --- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.
- (iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:
 - --- Space applications
 - --- Telecommunication equipment [trunk lines]
 - --- Nuclear power control equipment
 - --- Medical and other life support equipment (e.g., scuba).
- · If the SHARP devices listed in this publication fall within the scope of strategic products described in the Foreign Exchange and Foreign Trade Law of Japan, it is necessary to obtain approval to export such SHARP devices.
- · This publication is the proprietary product of SHARP and is copyrighted, with all rights reserved. Under the copyright laws, no part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, for any purpose, in whole or in part, without the express written permission of SHARP. Express written permission is also required before any use of this publication may be made by a third party.
- Contact and consult with a SHARP representative if there are any questions about the contents of this publication.